

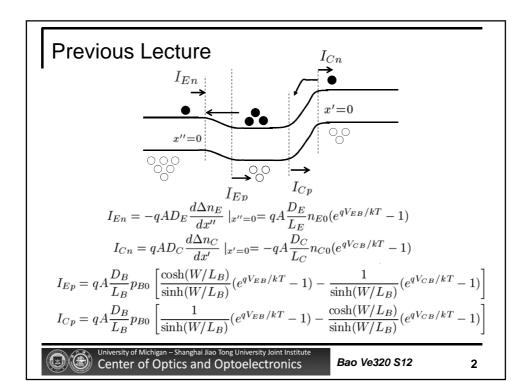
VE 320 – Summer 2012 Introduction to Semiconductor Device

Non-ideal Effects

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NANO ENERGY LAB

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Terminal Currents

$$\begin{split} I_E = & qA \Big[\Big(\frac{D_E}{L_E} n_{E0} + \frac{D_B}{L_B} p_{B0} \frac{\cosh(W/L_B)}{\sinh(W/L_B)} \Big) \left(e^{qV_{EB}/kT} - 1 \right) \\ & - \Big(\frac{D_B}{L_B} p_{B0} \frac{1}{\sinh(W/L_B)} \Big) \left(e^{qV_{CB}/kT} - 1 \right) \Big] \\ I_C = & qA \Big[\Big(\frac{D_B}{L_B} p_{B0} \frac{1}{\sinh(W/L_B)} \Big) \left(e^{qV_{EB}/kT} - 1 \right) \\ & - \Big(\frac{D_C}{L_C} n_{C0} + \frac{D_B}{L_B} p_{B0} \frac{\cosh(W/L_B)}{\sinh(W/L_B)} \Big) \left(e^{qV_{CB}/kT} - 1 \right) \Big] \end{split}$$

- Why BJT is not equivalent to two pn junction diode?
- What happens if W >> LB?



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Performance Parameters

$$\gamma = \frac{I_{Ep}}{I_E} = \frac{I_{Ep}}{I_{Ep} + I_{En}}$$

$$\alpha_T = \frac{I_{Cp}}{I_{Ep}}$$

$$\alpha_{dc} = \gamma \alpha_T = \frac{I_{Cp}}{I_E} \approx \frac{I_C}{I_E}$$

$$\gamma = \frac{I_{Ep}}{I_E} = \frac{I_{Ep}}{I_{Ep} + I_{En}}$$
 Without narrow base assumption.
$$\gamma = \left[1 + \left(\frac{D_E L_B N_B}{D_B L_E N_E}\right) \frac{\sinh(W/L_B)}{\cosh(W/L_B)}\right]^{-1}$$

$$\alpha_{T} = \left[\cosh(W/L_B)\right]^{-1}$$

$$\alpha_{dc} = \gamma \alpha_T = \frac{I_{Cp}}{I_E} \approx \frac{I_C}{I_E}$$

$$\alpha_{dc} = \left[\cosh(W/L_B) + \left(\frac{D_E L_B N_B}{D_B L_E N_E}\right) \sinh(W/L_B)\right]^{-1}$$

$$\beta_{dc} = \left[\cosh(W/L_B) + \left(\frac{D_E L_B N_B}{D_B L_E N_E}\right) \sinh(W/L_B) - 1\right]^{-1}$$

$$\beta_{dc} = \left[\cosh(W/L_B) + \left(\frac{D_E L_B N_B}{D_B L_E N_E}\right) \sinh(W/L_B) - 1\right]^{-1}$$

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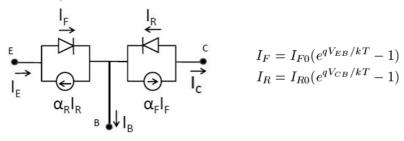
Generally one want large common emitter current gain. Then the doping concentration in the base should be as small as possible. However ...



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Ebers-Moll Equations

Node equation for BJT terminals



$$I_E = I_{F0}(e^{qV_{EB}/kT} - 1) - \alpha_R I_{R0}(e^{qV_{CB}/kT} - 1)$$

$$I_C = \alpha_F I_{F0}(e^{qV_{EB}/kT} - 1) - I_{R0}(e^{qV_{CB}/kT} - 1)$$

The four parameters can be treated as empirical parameters.



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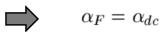
More about Ebers-Moll Equations

Exercise 11.5 Forward Current Gain

$$\alpha_F = \frac{qA \frac{D_B}{L_B} \frac{p_{B0}}{\sinh(W/L_B)}}{qA \left(\frac{D_E}{L_E} n_{E0} + \frac{D_B}{L_B} p_{B0} \frac{\cosh(W/L_B)}{\sinh(W/L_B)}\right)}$$

$$\alpha_F = \left[\cosh(W/L_B) + \left(\frac{D_E L_B n_{E0}}{D_B L_E p_{B0}} \right) \sinh(W/L_B) \right]^{-1}$$

$$n_{E0}/p_{B0} = N_B/N_E$$





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Input and Output

(1) Common base input $[I_E = I_E (V_{EB}, V_{CB})]$

$$I_{\rm E} = I_{\rm F0} (e^{qV_{\rm EB}/kT} - 1) - \alpha_{\rm R} I_{\rm R0} (e^{qV_{\rm CB}/kT} - 1)$$

(2) Common base output $[I_{\rm C} = I_{\rm C} (V_{\rm CB}, I_{\rm E})]$

$$I_{\rm C} = \alpha_{\rm F} I_{\rm E} - (1 - \alpha_{\rm F} \alpha_{\rm R}) I_{\rm R0} (e^{qV_{\rm CB}/kT} - 1)$$

(3) Common emitter input $[I_{\rm B} = I_{\rm B} (V_{\rm EB}, V_{\rm EC})]$

$$I_{\rm B} \, = \, [(1 \, - \, \alpha_{\rm F}) I_{\rm F0} \, + \, (1 \, - \, \alpha_{\rm R}) I_{\rm R0} e^{\, - \, q V_{\rm EC}/kT}] \, \, e^{\, q V_{\rm EB}/kT} \,$$

$$- [(1 - \alpha_{\rm F})I_{\rm F0} + (1 - \alpha_{\rm R})I_{\rm R0}]$$

(4) Common emitter output $[I_{\rm C} = I_{\rm C} (V_{\rm EC}, I_{\rm B})]$

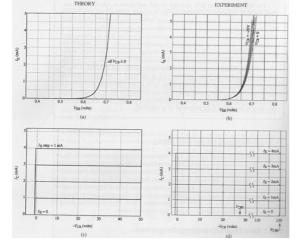
$$I_{\rm C} = \frac{(\alpha_{\rm F} I_{\rm F0} - I_{\rm R0} e^{-qV_{\rm EC}/kT})[I_{\rm B} + (1-\alpha_{\rm F})I_{\rm F0} + (1-\alpha_{\rm R})I_{\rm R0}]}{(1-\alpha_{\rm F})I_{\rm F0} + (1-\alpha_{\rm R})I_{\rm R0} e^{-qV_{\rm EC}/kT}} + I_{\rm R0} - \alpha_{\rm F} I_{\rm F0}$$



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Ideal and Non-ideal



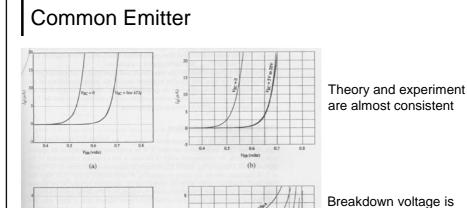
Input current increases with increasing negative values of VCB

Break down at large -VcB

Common base input and output

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lower than common base breakdown. Output current increases

with VEC



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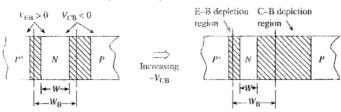
Base Width Modulation

The plots are generated with the assumption of $W=W_B$

$$I_{E} = qA \left[\left(\frac{D_{E}}{L_{E}} n_{E0} + \frac{D_{B}}{L_{B}} p_{B0} \frac{\cosh(W/L_{B})}{\sinh(W/L_{B})} \right) (e^{qV_{EB}/kT} - 1) - \left(\frac{D_{B}}{L_{B}} p_{B0} \frac{1}{\sinh(W/L_{B})} \right) (e^{qV_{CB}/kT} - 1) \right]$$

$$I_E \approx qA \frac{D_B}{W} p_{B0} e^{qV_{EB}/kT}$$

Common base input is dependent on the base width.



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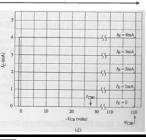
Base Width Modulation (Early Effect)

 $\beta_{dc} = \left[\frac{D_E N_B W}{D_B N_E L_E} + \frac{1}{2} \left(\frac{W}{L_B} \right)^2 \right]^{-1}$

 $\alpha_{dc} = \left[1 + \frac{D_E N_B W}{D_B N_E L_E} + \frac{1}{2} \left(\frac{W}{L_B}\right)^2\right]^{-1}$

Do you see the problem here? $I_C \qquad \qquad I_B \qquad \qquad V_{EC}$

Common emitter current gain is sensitive to base width but common base current gain is not.



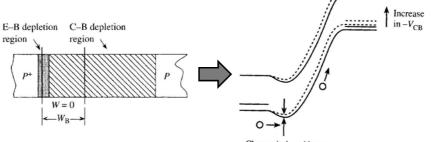
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Punch-Through



Change induced here by increase in $-V_{CB}$

- Base width modulation results in zero quasi-neutral width in the base region.
- The barrier can be reduced by C-B bias.
- If it occurs, it limits the maximum voltage can be applied on the C-B diode.

Why the base doping cannot be too low?

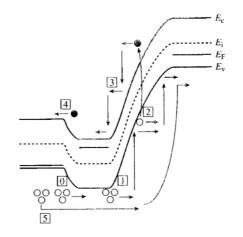
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Avalanche Breakdown

- Common base: breakdown occurs when the C-B diode breakdown
- Common emitter: breakdown occurs at a lower VcE voltage.

Base current is held constant so that the extra electrons have be injected into the emitter, which creates extra holes injected into the collector.



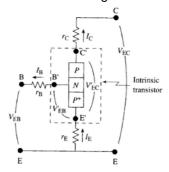
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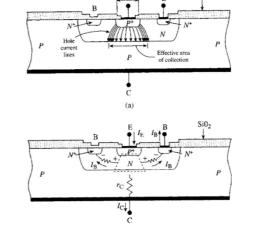
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Geometric Effect

- Emitter area and collector area are not the same
- · Series resistance
- · Current crowding





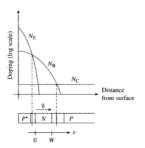
Can you see another reason why base doping cannot be too low?

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R-G Current / Graded Base

- In most operation conditions the R-G current is generally not important. For small forward bias of the E-B junction, the R-G current is dominant.
- The doping profile in the base in "graded" and therefore induces an electric field in the base.



$$J_{\rm N} = q\mu_{\rm n}n\mathcal{E} + qD_{\rm N}\frac{dn}{dx} = 0$$

$$\mathcal{E}(x) = -\frac{D_{\rm N}}{\mu_{\rm n}} \frac{dn/dx}{n} \cong -\frac{kT}{q} \frac{dN_{\rm B}(x)/dx}{N_{\rm B}(x)}$$

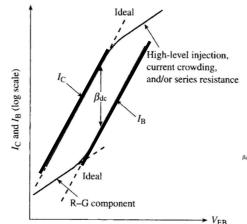
The electric field assists the transport of minority carriers in the base, and thus reduces the R-G in the base. This is beneficial.



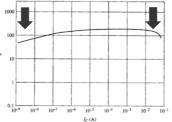
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Gummel Plot



In a certain region, Ic is proportional to IB and the signal is amplified. Outside this region the non-ideality is due to similar reasons as a non-ideal diode.



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Self-test

- How to obtain the ideal BJT current-voltage relationship?
- How can BJT amplify a signal?
- What are the reasons for the nonideality of BJT?



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